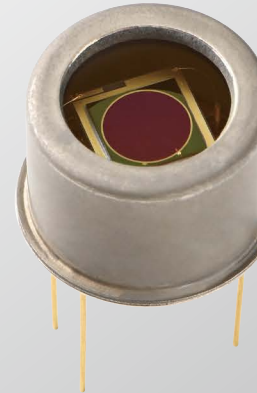
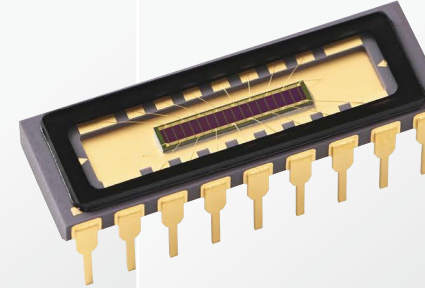
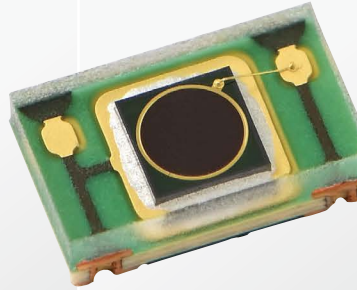


Supports various spectral response ranges in the infrared region

Infrared detectors



Supports various spectral response ranges in the infrared region

Infrared detectors are widely used in fields including measurement, analysis, industry, communications, agriculture, medicine, physical-and-chemical science, astronomy, and aerospace. Based on its long experience in optical technology, Hamamatsu provides a wide lineup of products for the infrared region.



When using infrared detectors, the following points should be taken into consideration for making a device selection.

Spectral response

We offer detectors with various spectral responses (P.5). By cooling the element, the spectral response of InGaAs, InAs, InSb, and InAsSb shifts to the short-wavelength side.

Response speed

Various detectors are available with different response speeds.

Photosensitive area, number of elements

Various types are available, ranging from small to large photosensitive area sizes. We also offer multi-element types suitable for high-speed multi-channel spectrophotometry.

Cooling

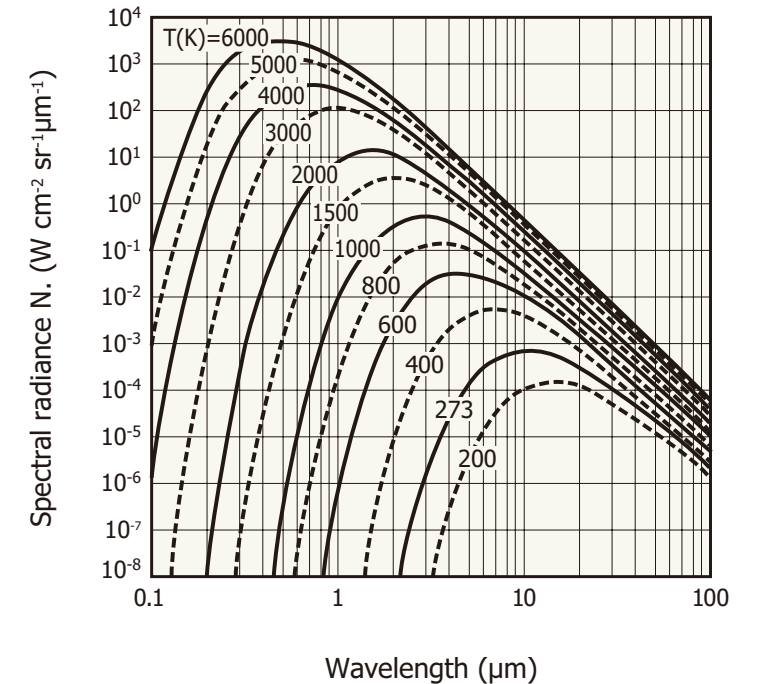
Besides the easy-to-use non-cooled type, we offer a TE-cooled type that does not require coolant, as well as a dewar type (cooled with liquid nitrogen) that realizes low noise.

Object temperature

When selecting a detector based on the temperature of the object, it is necessary to consider the energy distribution (wavelength dependence of energy) radiated from the object. When the temperature of the object changes, its radiant energy distribution changes according to the law of black body radiation (Planck's law of radiation). (See the figure on the right.) The following relationship exists between the peak sensitivity wavelength λ_p (μm) and the object temperature T (K).

$$\lambda_p \cdot T = 2897.9$$

● Law of black body radiation (Planck's law)

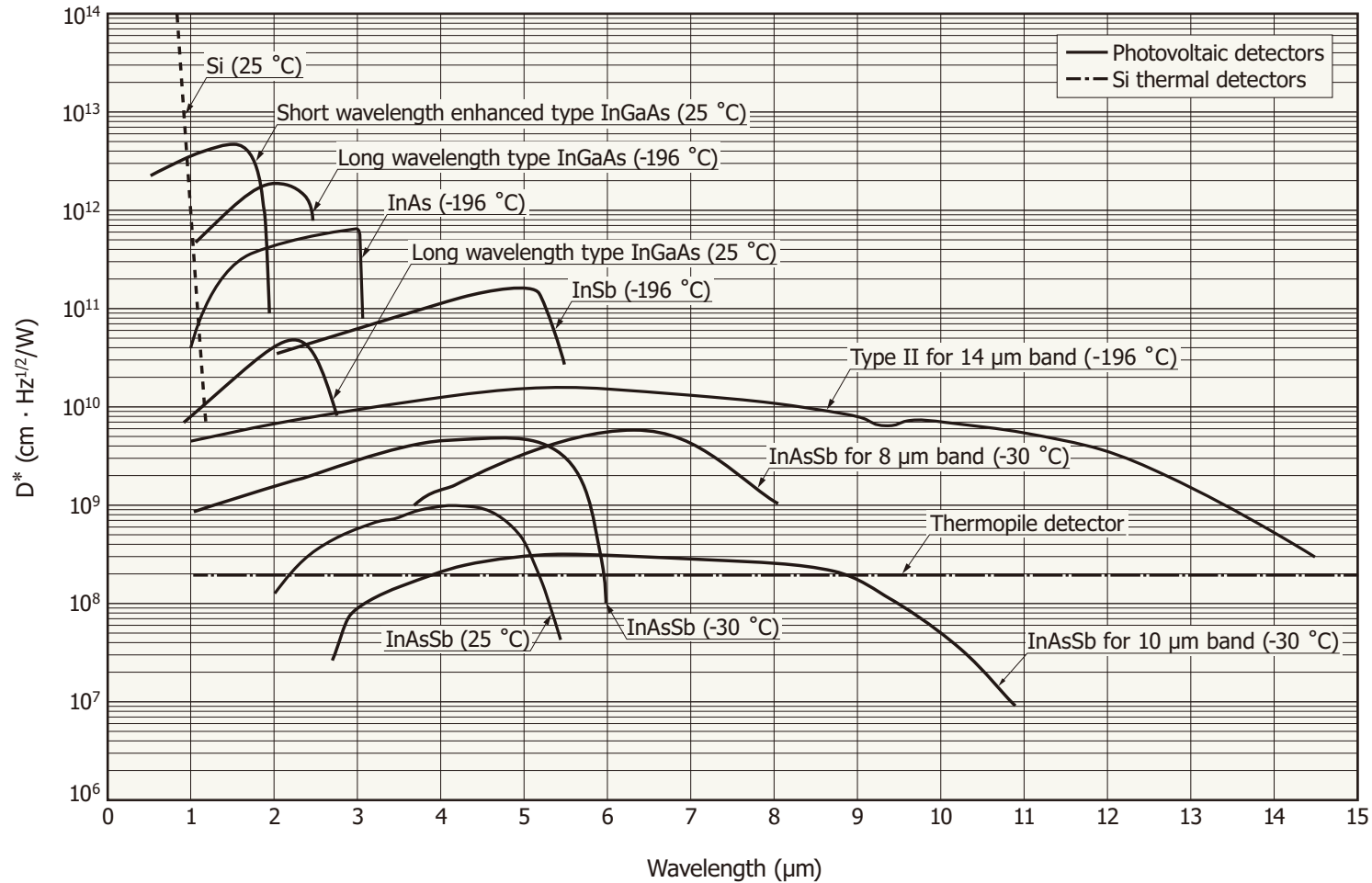


KIRDB0014EB

Product name	Spectral response range (μm)	Features	Main applications
InGaAs PIN photodiode	0.5 to 1.7 μm	<ul style="list-style-type: none"> High-speed response Various types of photosensitive areas, arrays, and packages available TE-cooled type available 	<ul style="list-style-type: none"> Optical fiber communications Power meters Gas analysis Moisture meters NIR (near infrared) photometry
	0.9 to 1.7 μm		
	0.9 to 1.9 μm		
	0.9 to 2.1 μm		
	0.9 to 2.6 μm		
InGaAs APD	0.95 to 1.7 μm	<ul style="list-style-type: none"> Low dark current Low capacitance High sensitivity 	<ul style="list-style-type: none"> Distance measurement LiDAR OTDR



Product name	Spectral response range (μm)	Features	Main applications
InAs photovoltaic detector	1 to 3.8 μm	<ul style="list-style-type: none"> Covers a spectral response range close to PbS but offers higher response speed 	<ul style="list-style-type: none"> Gas measurement Infrared measurement FTIR
InSb photovoltaic detector	1 to 5.5 μm	<ul style="list-style-type: none"> High sensitivity in the 3 to 5 μm band makes it suitable for analysis of gases such as CO₂, SO_x. 	<ul style="list-style-type: none"> FTIR Gas measurement Radiation thermometers Flame detection
InAsSb photovoltaic detector	1 to 11 μm	<ul style="list-style-type: none"> High-speed response, high sensitivity, and high reliability infrared detectors in the 5 μm, 8 μm, or 10 μm band Covers a spectral response range (5 μm band) close to PbSe but offers higher response speed 	<ul style="list-style-type: none"> Gas measurement FTIR Radiation thermometers Laser monitors
Type II superlattice infrared detector	1 to 14.5 μm	<ul style="list-style-type: none"> This sensor has expanded sensitivity up to the 14 μm band without using mercury or cadmium restricted by RoHS directive. 	<ul style="list-style-type: none"> FTIR Gas measurement Radiation thermometers
Thermopile detector	1 to 25 μm	<ul style="list-style-type: none"> Sensors that generate thermoelectromotive force in proportion to the incident infrared light energy 	<ul style="list-style-type: none"> Gas measurement CO₂ density measurement
Two-color detector	Si + InGaAs	0.32 to 2.55 μm	<ul style="list-style-type: none"> Spectrophotometers Laser monitors Flame monitors Radiation thermometers
	Si + InAsSb	0.32 to 5.3 μm	
	InGaAs + InGaAs	0.9 to 2.55 μm	

● Spectral response (typical example)

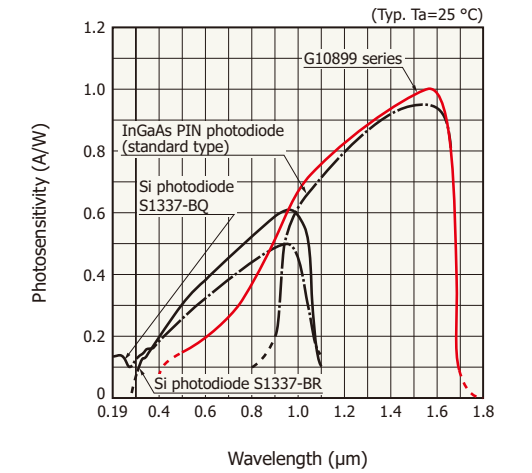


Short wavelength enhanced type

(Typ. Ta=25 °C)

Type no.	Cooling	Photosensitive area (mm)	Spectral response range λ (μm)	Peak sensitivity wavelength λ_p (μm)	Cutoff frequency f_c $V_R=1\text{ V}$ (MHz)	Package	Photo	Dedicated amplifier (sold separately)
G10899-003K	Non-cooled	$\phi 0.3$	0.5 to 1.7	1.55	300	TO-18		C4159-03
G10899-005K		$\phi 0.5$			150			
G10899-01K		$\phi 1$			45			
G10899-02K		$\phi 2$			10	TO-5		
G10899-03K		$\phi 3$			5			

● Spectral response



KIRDB0408EC

Standard type

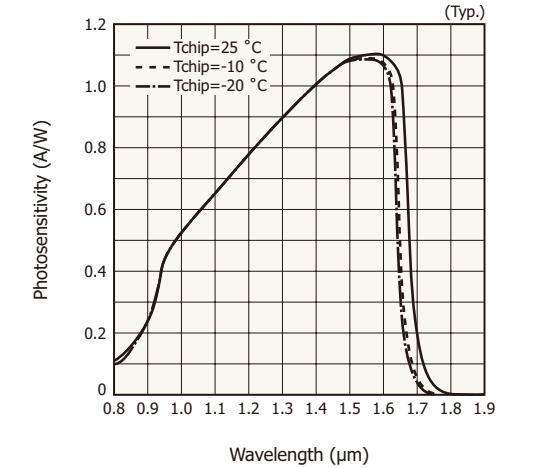
Metal package

Various sizes of photosensitive areas are available.

(Typ. Ta=25 °C, unless otherwise noted)

Type no.	Cooling	Photosensitive area (mm)	Spectral response range λ (μm)	Peak sensitivity wavelength λ_p (μm)	Cutoff frequency f_c (MHz)	Package	Photo	Options (sold separately)
G12180-003A	Non-cooled	$\phi 0.3$	0.9 to 1.7	1.55	600 (VR=5 V)	TO-18		C4159-03
G12180-005A		$\phi 0.5$			200 (VR=5 V)			
G12180-010A		$\phi 1$			60 (VR=5 V)			
G12180-020A		$\phi 2$			13 (VR=1 V)	TO-5		
G12180-030A		$\phi 3$			7 (VR=1 V)			
G12180-050A		$\phi 5$			3 (VR=1 V)	TO-8		
G8370-81*		$\phi 1$			35 (VR=1 V)	TO-18		
G8370-82*		$\phi 2$			4 (VR=1 V)	TO-5		
G8370-83*		$\phi 3$			2 (VR=1 V)			
G8370-85*		$\phi 5$			0.6 (VR=1 V)	TO-8		
G12180-110A	One-stage TE-cooled (Tchip=-10 °C)	$\phi 1$	0.9 to 1.67		40 (VR=1 V)	TO-8		C4159-03 A3179 C1103-04
G12180-120A		$\phi 2$			13 (VR=1 V)			
G12180-130A		$\phi 3$			7 (VR=1 V)			
G12180-150A		$\phi 5$			3 (VR=1 V)			
G12180-210A	Two-stage TE-cooled (Tchip=-20 °C)	$\phi 1$	0.9 to 1.65		40 (VR=1 V)	TO-8		C4159-03 A3179-01 C1103-04
G12180-220A		$\phi 2$			13 (VR=1 V)			
G12180-230A		$\phi 3$			7 (VR=1 V)			
G12180-250A		$\phi 5$			3 (VR=1 V)			
G6854-01	Non-cooled	$\phi 0.08$	0.9 to 1.7		2000 (VR=5 V)	With CD lens TO-18		—











Spectral response



* Low PDL type

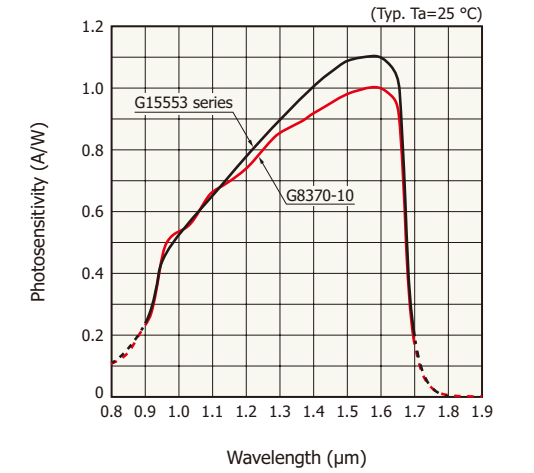
Standard type

Ceramic package, plastic package

Type no.	Photosensitive area (mm)	Spectral response range λ (μm)	Peak sensitivity wavelength λ_p (μm)	Cutoff frequency f_c $V_R=5\text{ V}$ (MHz)	Package	Photo (Typ. $T_a=25\text{ }^\circ\text{C}$)
G8370-10	$\phi 10$	0.9 to 1.7	1.55	0.1*	Ceramic	
G15553-003C	$\phi 0.3$			600	Ceramic (unsealed, surface mount type)	
G15553-005C	$\phi 0.5$			200		
G15553-010C	$\phi 1$			60		
G11193-02R	$\phi 0.2$			1000	Ceramic (surface mount type)	
G11193-03R	$\phi 0.3$			500		
G11193-10R	$\phi 1$			60		
G13176-003P	$\phi 0.3$			600	Plastic COB (surface mount type)	
G13176-010P	$\phi 1$			60		
G14448-003L	$\phi 0.3$			600	Plastic COB with lens (surface mount type)	

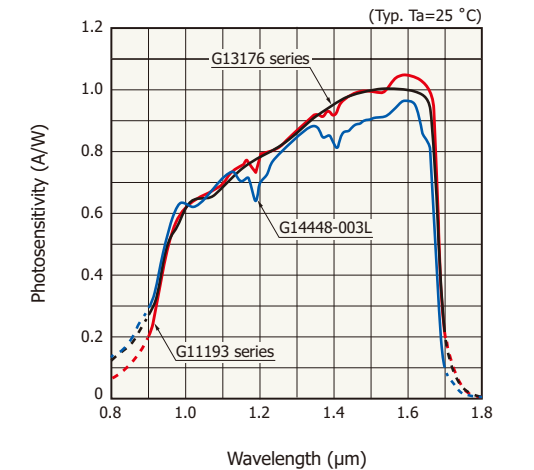
* $V_R=0\text{ V}$

● Spectral response
[G8370-10, G15553 series]



KIRDB0719EA

[G11193, G13176 series, G14448-003L]






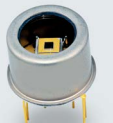
KIRDB0646EC

Long wavelength type

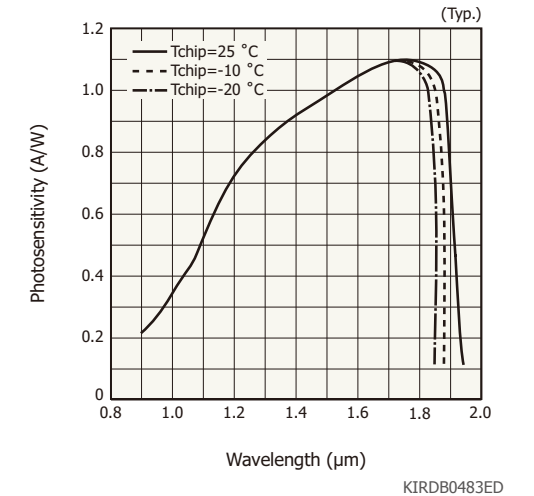
Peak sensitivity wavelength: 1.75 μm

These are suitable for light measurement around 1.7 μm .

(Typ. $T_a=25\text{ }^\circ\text{C}$, unless otherwise noted)

Type no.	Cooling	Photosensitive area (mm)	Spectral response range λ (μm)	Peak sensitivity wavelength λ_p (μm)	Cutoff frequency f_c $V_R=0\text{ V}$ (MHz)	Package	Photo	Options (sold separately)	
G12181-003K	Non-cooled	$\phi 0.3$	0.9 to 1.9	1.75	90	TO-18		C4159-03	
G12181-005K		$\phi 0.5$			35				
G12181-010K		$\phi 1$			10				
G12181-020K		$\phi 2$			2.5	TO-5			
G12181-030K		$\phi 3$			1.5				
G12181-103K	One-stage TE-cooled ($T_{\text{chip}}=-10\text{ }^\circ\text{C}$)	$\phi 0.3$	0.9 to 1.87		140	TO-8		C4159-03 A3179 C1103-04	
G12181-105K		$\phi 0.5$			50				
G12181-110K		$\phi 1$			16				
G12181-120K		$\phi 2$			3.5				
G12181-130K		$\phi 3$			1.8				
G12181-203K	Two-stage TE-cooled ($T_{\text{chip}}=-20\text{ }^\circ\text{C}$)	$\phi 0.3$	0.9 to 1.85		150	TO-8		C4159-03 A3179-01 C1103-04	
G12181-205K		$\phi 0.5$			53				
G12181-210K		$\phi 1$			17				
G12181-220K		$\phi 2$			3.7				
G12181-230K		$\phi 3$			1.9				

Spectral response



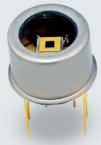


Long wavelength type

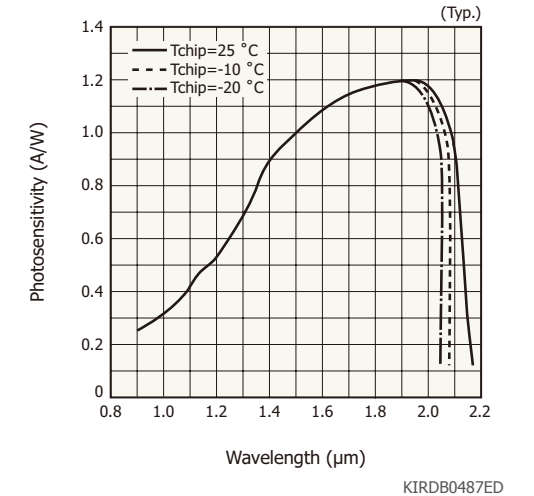
Peak sensitivity wavelength: 1.95 μm

These are suitable for optical measurement in the moisture absorption wavelength band in the 1.9 μm band.

(Typ. $T_a=25\text{ }^\circ\text{C}$, unless otherwise noted)

Type no.	Cooling	Photosensitive area (mm)	Spectral response range λ (μm)	Peak sensitivity wavelength λ_p (μm)	Cutoff frequency f_c $V_R=0\text{ V}$ (MHz)	Package	Photo	Options (sold separately)
G12182-003K	Non-cooled	$\phi 0.3$	0.9 to 2.1	1.95	90	TO-18		C4159-03
G12182-005K		$\phi 0.5$			35			
G12182-010K		$\phi 1$			10			
G12182-020K		$\phi 2$			2.5	TO-5		
G12182-030K		$\phi 3$			1.5			
G12182-103K	One-stage TE-cooled ($T_{\text{chip}}=-10\text{ }^\circ\text{C}$)	$\phi 0.3$	0.9 to 2.07		140	TO-8		C4159-03 A3179 C1103-04
G12182-105K		$\phi 0.5$			50			
G12182-110K		$\phi 1$			16			
G12182-120K		$\phi 2$			3.5			
G12182-130K		$\phi 3$			1.8			
G12182-203K	Two-stage TE-cooled ($T_{\text{chip}}=-20\text{ }^\circ\text{C}$)	$\phi 0.3$	0.9 to 2.05		150	TO-8		C4159-03 A3179-01 C1103-04
G12182-205K		$\phi 0.5$			53			
G12182-210K		$\phi 1$			17			
G12182-220K		$\phi 2$			3.7			
G12182-230K		$\phi 3$			1.9			

Spectral response



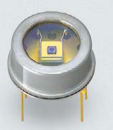
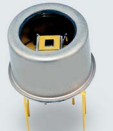



Long wavelength type

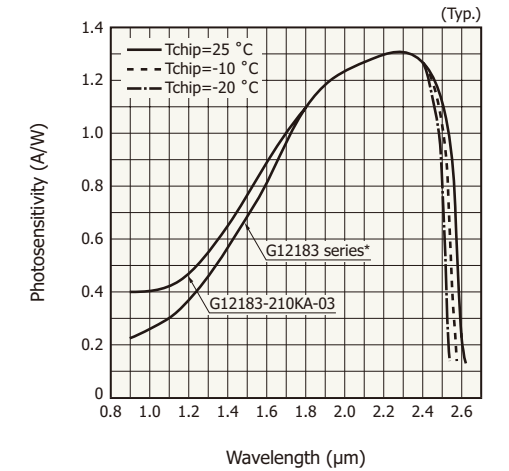
Peak sensitivity wavelength: 2.3 μm

These are suitable for NIR (near infrared) spectrometers.

(Typ. Ta=25 °C, unless otherwise noted)

Type no.	Cooling	Photosensitive area (mm)	Spectral response range λ (μm)	Peak sensitivity wavelength λp (μm)	Cutoff frequency fc VR=0 V (MHz)	Package	Photo	Options (sold separately)
G12183-003K	Non-cooled	φ0.3	0.9 to 2.6	2.3	50	TO-18		C4159-03
G12183-005K		φ0.5			20			
G12183-010K		φ1			6			
G12183-020K		φ2			1.5	TO-5		
G12183-030K		φ3			0.8			
G12183-103K	One-stage TE-cooled (Tchip=-10 °C)	φ0.3	0.9 to 2.57		70	TO-8		
G12183-105K		φ0.5			25			
G12183-110K		φ1			7			
G12183-120K		φ2			2			
G12183-130K		φ3			0.9			
G12183-203K	Two-stage TE-cooled (Tchip=-20 °C)	φ0.3	0.9 to 2.55		75	TO-8		
G12183-205K		φ0.5			28			
G12183-210K		φ1			8			
G12183-220K		φ2			2.3			
G12183-230K		φ3			1			
G12183-210KA-03		φ1		4	TO-66		C4159-03 A3179-01 C1103-04	

● Spectral response





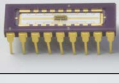
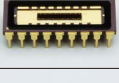



* Excluding G12183-210KA-03

KIRDB0491EF

InGaAs PIN photodiode arrays

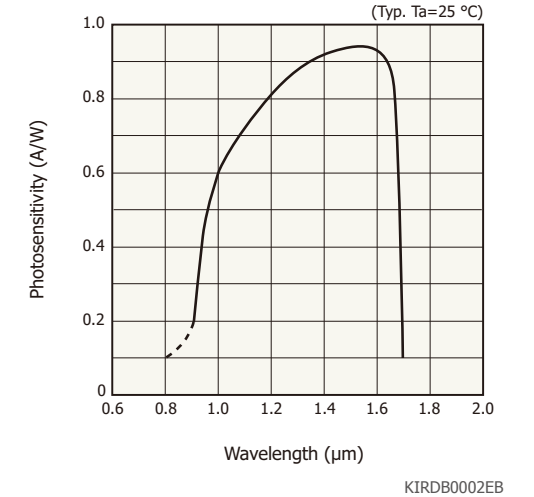
4-segmented type and 16, 32, 40, 46-element arrays are available.

(Typ. Ta=25 °C)

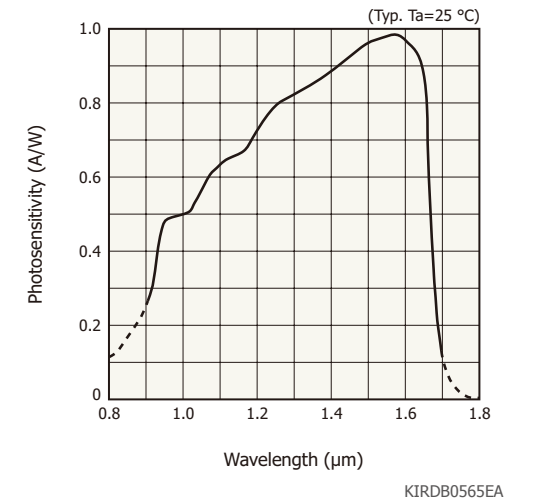
Type no.	Photosensitive area (mm)	Number of elements	Spectral response range λ (μm)	Peak sensitivity wavelength λ_p (μm)	Package	Photo
G6849-01	$\phi 1$	4-segment	0.9 to 1.7	1.55	TO-5	
G6849	$\phi 2$	4-segment				
G7151-16	0.08 x 0.2	16 elements				
G12430-016D	0.45 x 1.0	16 elements				
G12430-032D	0.2 x 1.0	32 elements				
G12430-046D	0.2 x 1.0	46 elements				
G8909-01	$\phi 0.08$	40 elements			Ceramic (unsealed)	

● Spectral response

[G6849 series, G7151-16, G8909-01]




[G12430 series]



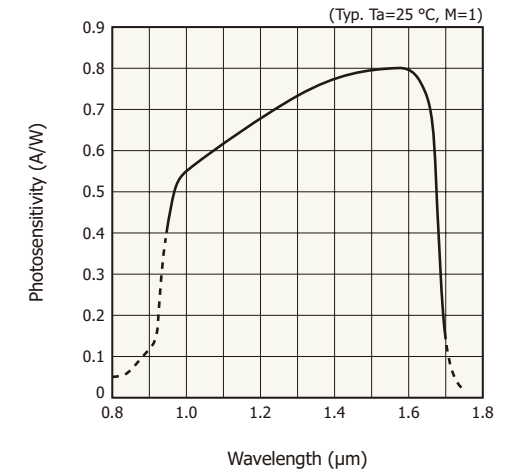
InGaAs APD

The G14858-0020AA is used for distance measurement, low-light-level detection, and so on.

(Typ.)

Type no.	Photosensitive area (mm)	Spectral response range (μm)	Breakdown voltage max. $I_D=100 \mu\text{A}$ (V)	Cutoff frequency $R_L=50 \Omega$ (MHz)	Terminal capacitance (pF)	Gain $\lambda=1.55 \mu\text{m}$	Package	Photo
G14858-0020AA	$\phi 0.2$	0.95 to 1.7	80	900	2.0	30	TO-18	

● Spectral response






KAPDB0417EA

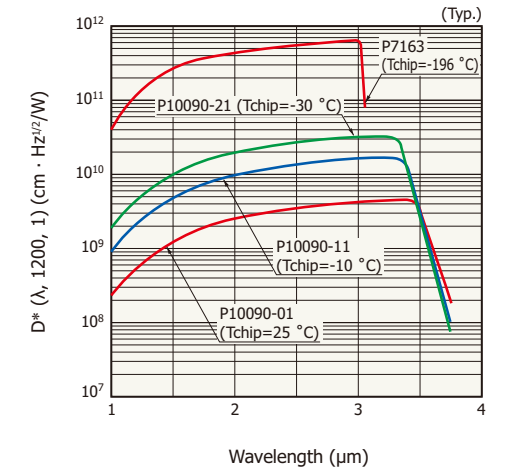
InAs photovoltaic detectors

The InAs photovoltaic detectors are low-noise, high-speed response infrared detectors that can detect up to around 3.5 μm .

(Typ.)



Type no.	Cooling	Photosensitive area (mm)	Cutoff wavelength λ_c (μm)	Peak sensitivity wavelength λ_p (μm)	Package	Photo	Options (sold separately)
P10090-01	Non-cooled	$\phi 1$	3.65	3.35	TO-5		C4159-07
P10090-11	One-stage TE-cooled (Tchip=-10 °C)		3.55	3.30	TO-8		A3179-01 C1103-04 C4159-06
P10090-21	Two-stage TE-cooled (Tchip=-30 °C)		3.45	3.25			A3179-01 C1103-04 C4159-06
P7163	Liquid nitrogen (Tchip=-196 °C)		3.10	3.00	Metal dewar		C4159-05

● Spectral response



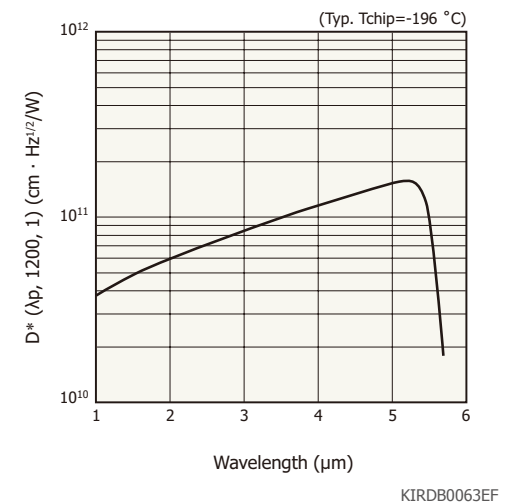
InSb photovoltaic detectors

These are the most sensitive and fastest response detectors among our products in 5 μm band.

Type no.	Cooling	Photosensitive area (mm)	Cutoff wavelength λ_c (μm)	Peak sensitivity wavelength λ_p (μm)	Package	Photo	Dedicated amplifier (sold separately)
P5968-060	Liquid nitrogen (Tchip=-196 °C)	φ0.6	5.5	5.3	Metal dewar		C4159-01
P5968-100		φ1					C4159-04
P5968-200		φ2					Custom product
P5968-300		φ3					—
P4247-16		0.25 × 1.4 (1 × 16 elements)					—
P4247-44		0.45 × 0.45 (4 × 4 elements)					—







(Typ.)

● Spectral response

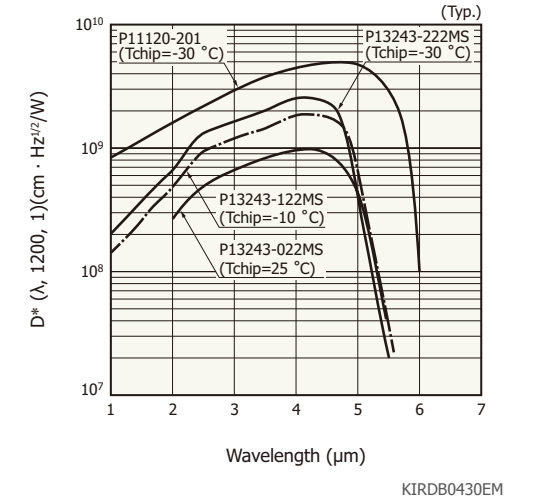


Front-illuminated type

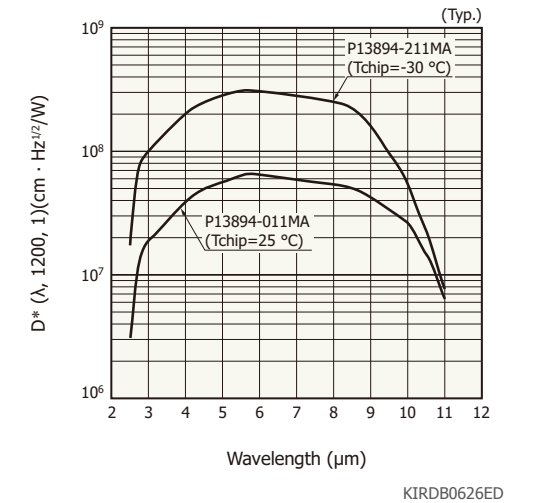
These are InAsSb photovoltaic detectors with cutoff wavelengths of 5 μm band or 10 μm band. The TE-cooled type capable of stable S/N measurement are available.

Type no.	Cooling	Photosensitive area (mm)	Cutoff wavelength λ _c (μm)	Peak sensitivity wavelength λ _p (μm)	Package	Photo	Options (sold separately)
P11120-201	Two-stage TE-cooled (T _{chip} =-30 °C)	φ1	5.9	4.9	TO-8		A3179-01 C1103-04 C4159-07
P13243-022MS	Non-cooled	2 × 2	5.3	4.1	TO-5		C4159-01
P13243-122MS	One-stage TE-cooled (T _{chip} =-10 °C)		TO-8			A3179 C1103-04 C4159-01	
P13243-222MS	Two-stage TE-cooled (T _{chip} =-30 °C)		TO-8			A3179-01 C1103-04 C4159-01	
P13894-011MA	Non-cooled		1 × 1		11.0	TO-5	
P13894-211MA	Two-stage TE-cooled (T _{chip} =-30 °C)	10.2		TO-8		A3179-01 C1103-04 C4159-01	

● Spectral response [P11120-201, P13243 series]









[P13894 series]



Back-illuminated type

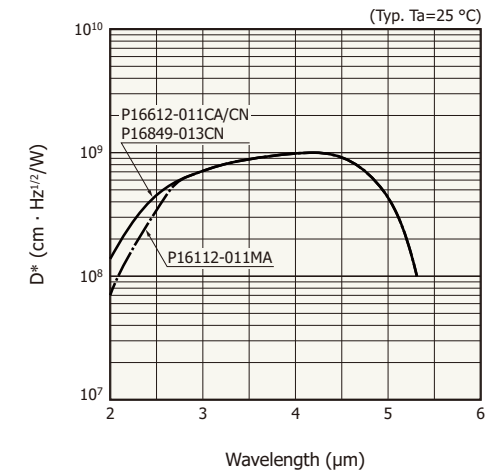
The back-illuminated type InAsSb photovoltaic detectors achieve cutoff wavelength of 5 μm, 8 μm, or 10 μm using Hamamatsu's unique crystal growth technology. Compared to the front-illuminated type, they achieve high sensitivity and improve the temperature characteristics of sensitivity.

(Typ.)

Type no.	Cooling	Photosensitive area (mm)	Cutoff wavelength λc (μm)	Peak sensitivity wavelength λp (μm)	Package	Photo	Dedicated amplifier (sold separately)
P16112-011MA	Non-cooled	0.7 × 0.7	5.3	4.1	TO-46		C4159-01
P16612-011CA							
P16612-011CN NEW							
P16613-011CN NEW							
P16614-011CN NEW							
P16849-013CN NEW		0.7 × 0.7 (two-element)	5.3	4.1	Ceramic (Surface mount type)		

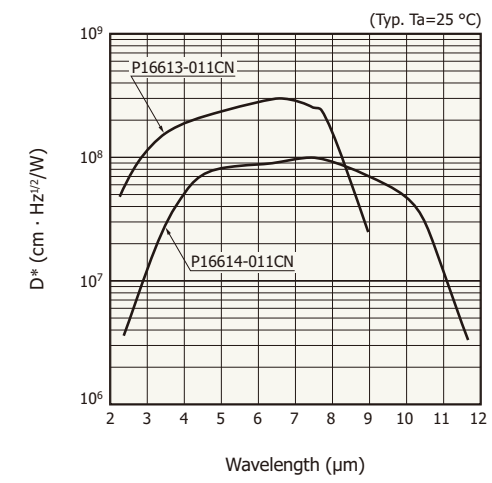
● Spectral response

[P16112-011MA, P16612 series, P16849-013CN]



KIRDB0715ED



[P16613-011CN, P16614-011CN]



KIRDB0733EA

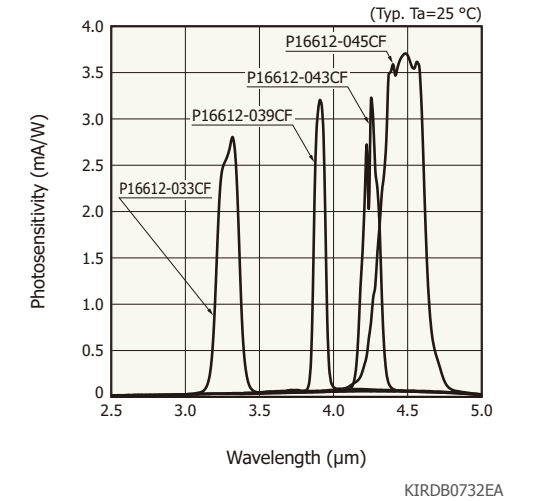
With band-pass filter

These are back-illuminated type InAsSb photovoltaic detectors that use a band-pass filter (center wavelength: 3.3 μm, 3.9 μm, 4.26 μm, 4.45 μm) for the window material. They are suitable for gas measurement (CH₄, CO₂) and flame detection.

Type no.	Cooling	Photosensitive area (mm)	Window material*	Package	Photo	Dedicated amplifier (sold separately)
P16612-033CF NEW	Non-cooled	0.7 × 0.7	BPF (3.3 μm)	Ceramic (Surface mount type)		C4159-01
P16612-039CF NEW			BPF (3.9 μm)			
P16612-043CF NEW			BPF (4.26 μm)			
P16612-045CF NEW			BPF (4.45 μm)			
P16849-011CF NEW		0.7 × 0.7 (two-element)	BPF (3.3 μm)			-
P16849-012CF NEW			BPF (3.9 μm)			
			BPF (3.9 μm)			
			BPF (4.26 μm)			

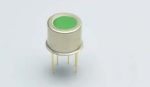
* BPF: band-pass filter

● Spectral response



With lens

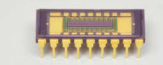

This is an InAsSb photovoltaic detector that achieves high sensitivity by mounting a lens on a chip with a back-illuminated structure. It is an electronically cooled type that provides a stable S/N.

Type no.	Cooling	Photosensitive area (mm)	Cutoff wavelength λ_c (μm)	Peak sensitivity wavelength λ_p (μm)	Package	Photo	Options (sold separately)
P12691-201G	Two-stage TE-cooled ($T_{\text{chip}}=-30\text{ }^\circ\text{C}$)	$\phi 1$	8.3	6.7	TO-8		A3179-01 C1103-04 C4159-07

(Typ.)

Arrays

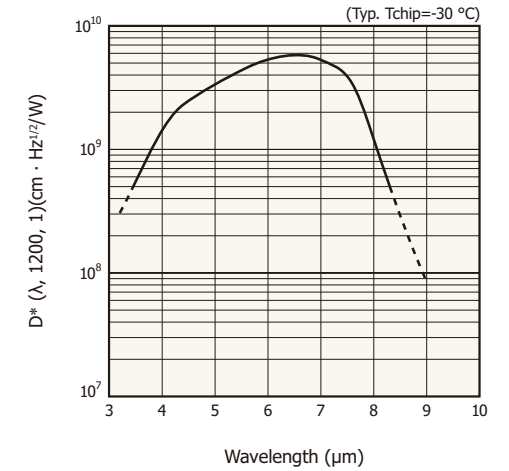
These are InAsSb arrays in DIP ceramic packages. Simultaneous measurement and wide range measurement are possible.

Type no.	Cooling	Photosensitive area (mm)	Cutoff wavelength λ_c (μm)	Peak sensitivity wavelength λ_p (μm)	Package	Photo	Dedicated amplifier (sold separately)
P15742-016DS	Non-cooled	0.45 × 0.7 (16 elements)	5.3	4.1	Ceramic		—
P15742-046DS		0.2 × 0.7 (46 elements)					

(Typ.)

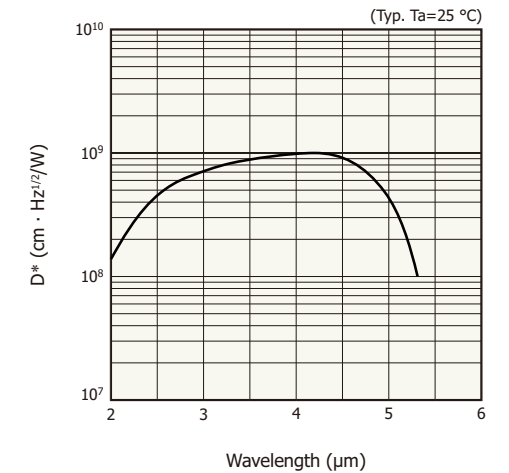
● Spectral response

[P12691-201G]



KIRDB0592EA

[P15742 series]




KIRDB0687EB

Type II superlattice infrared detectors

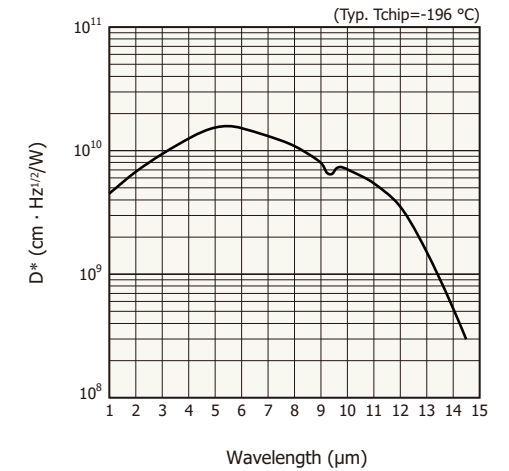
Type II superlattice infrared detector

The P15409-901 is a type II superlattice infrared detector with sensitivity expanded to the 14 μm band using Hamamatsu's unique crystal growth technology and process technology. This product is an environmentally friendly infrared detector and does not use mercury or cadmium, which are substances restricted by the RoHS directive. It is a replacement for conventional products that contain these substances.

Type no.	Cooling	Photosensitive area (mm)	Cutoff wavelength* λc (μm)	Peak sensitivity wavelength λp (μm)	Package	Photo	Dedicated amplifier (sold separately)
P15409-901	Liquid nitrogen (Tchip=-196 °C)	φ0.1	14.5	5.4	Metal dewar		C4159-01

* Wavelength at which signal/noise = 1


● Spectral response



KIRDB0673EB

Infrared detector module with preamp


This is an amplifier-integrated module that can detect infrared light simply by connecting a DC power supply.

Type no.	Detector	Photosensitive area (mm)	Cooling	Measurement condition	Cutoff wavelength λc (μm)	Peak sensitivity wavelength λp (μm)	Photo
				Chip temperature (°C)			
C15780-401	Type II superlattice (P15409-901)	φ0.1	Liquid nitrogen	-196	14.5	5.4	

Thermopile detectors (thermal detectors)

Single element


These are high-sensitivity Si thermopile detectors suitable for gas density measurement or the like. By attaching a band-pass filter to the thermopile detector, it is possible to measure the concentration of various gases. The T15770 is suitable for flame detection. (Typ.)

Type no.	Number of elements	Photosensitive area (mm)	Window material	Spectral response range (μm)	Package	Photo
T11361-01*	1	1.2 × 1.2	Si with AR coating	3 to 5	TO-18	
T15770			With band-pass filter	4.45		
T15962-01*			Si	1.1 or longer		

* Built-in thermistor

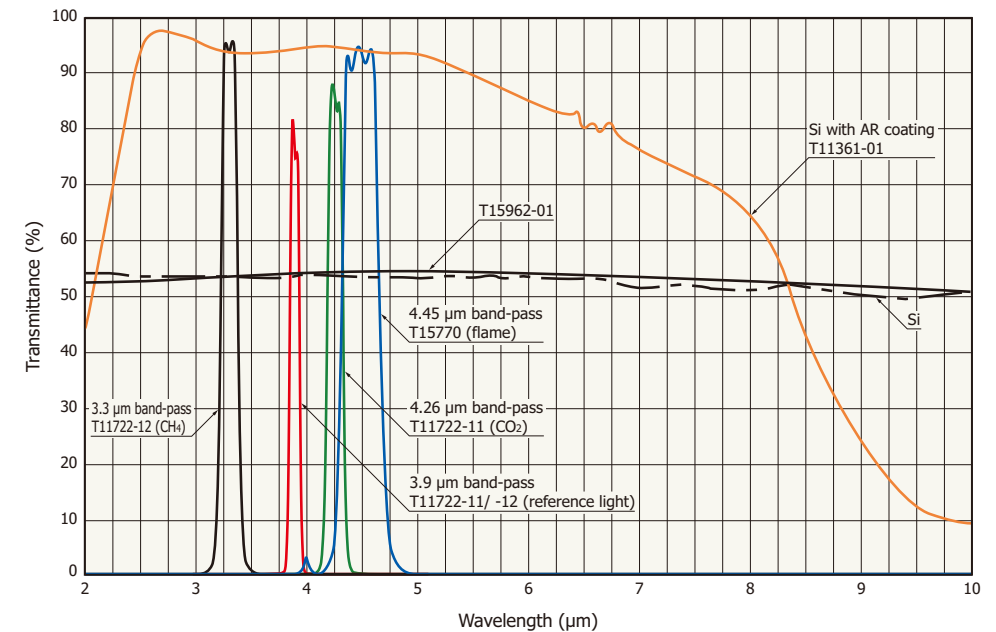
Dual element

These dual type thermopile detectors were developed to measure concentration of carbon dioxide (CO₂) and methane (CH₄) with high accuracy. They consist of two high-sensitivity Si thermopile chips and two band-pass filters so that two wavelengths can be detected simultaneously. (Typ.)

Type no.	Number of elements	Photosensitive area (mm)	Window material	Spectral response range (μm)	Package	Photo
T11722-11	2	1.2 × 1.2 (per element)	With band-pass filter	Reference light: 3.9 CO ₂ : 4.26	TO-5	
T11722-12				Reference light: 3.9 CH ₄ : 3.3		

● Spectral response (typical example)

Since thermopile detectors have no wavelength dependence, their spectral response is determined by the transmittance characteristics of window materials. Spectral transmittance characteristics of typical window materials are shown below. Please contact our sales office if you wish to replace a window material with the one shown below for thermopile detectors.














KIRDB0671ED

Two-color detectors

These sensors have two photosensors with different spectral response ranges arranged on the top and bottom of the same optical axis. They realize a wide spectral response range. The TE-cooled types improve the S/N and enable high accuracy measurement by cooling the element and keeping the temperature constant.

(Typ.)

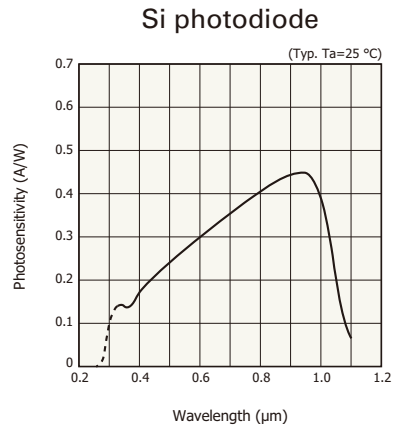
Type no.	Cooling	Detector	Photosensitive area (mm)	Spectral response range λ (μm)	Peak sensitivity wavelength λ_p (μm)	Photosensitivity S $\lambda=\lambda_p$ (A/W)	Package	Photo	Options (sold separately)								
K1713-003	Non-cooled	Si	2.4 × 2.4	0.32 to 5.3	0.94	0.45	TO-5		C9329 C4159-01								
		InAsSb	0.7 × 0.7			4.0				0.0039							
K1713-05			Si	2.4 × 2.4	0.32 to 1.7	0.94			0.45		C9329 C4159-03						
		InGaAs	φ0.5			1.55			0.55								
K1713-08			Si	2.4 × 2.4	0.32 to 2.6	0.94			0.45			C9329 C4159-03					
		InGaAs	φ1			2.3			0.60								
K1713-09			Si	2.4 × 2.4	0.32 to 1.7	0.94			0.45				C9329 C4159-03				
		InGaAs	φ1			1.55			0.55								
K11908-010K			InGaAs	2.4 × 2.4	0.9 to 2.55	1.55			0.95					C4159-03			
		InGaAs	φ1			2.1			1.0								
K13085-010K			InGaAs	2.4 × 2.4	0.9 to 1.85	1.55			0.95						C4159-03		
		InGaAs	φ1			1.75			0.8								
K3413-05	One-stage TE-cooled (Tchip=-10 °C)	Si	2.4 × 2.4	0.32 to 1.67	0.94	0.45	TO-8		C9329 C4159-03 A3179-03 C1103-04								
		InGaAs	φ0.5			1.55									0.55		
K3413-08			Si	2.4 × 2.4	0.32 to 2.57	0.94				0.45						C9329 C4159-03 A3179-03 C1103-04	
		InGaAs	φ1			2.3				0.60							
K3413-09			Si	2.4 × 2.4	0.32 to 1.67	0.94				0.45							C9329 C4159-03 A3179-03 C1103-04
		InGaAs	φ1			1.55				0.55							
K12728-010K	Non-cooled	Si	2.4 × 2.4	0.32 to 1.7	0.96	0.45	Ceramic (surface mount type)		-								
		InGaAs	φ1			1.55				0.55							
K12729-010K			InGaAs	2.4 × 2.4	0.9 to 2.55	1.55				0.95			-				
		InGaAs	φ1			2.1				1.0							

Two-color detectors

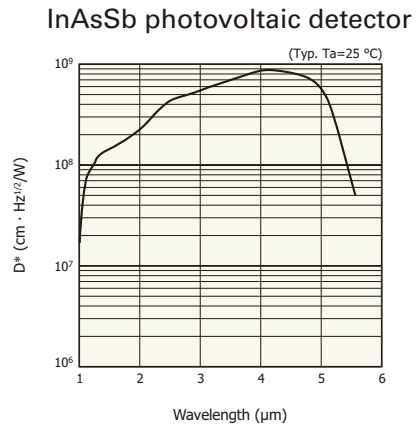
● Spectral response

[K1713-003]

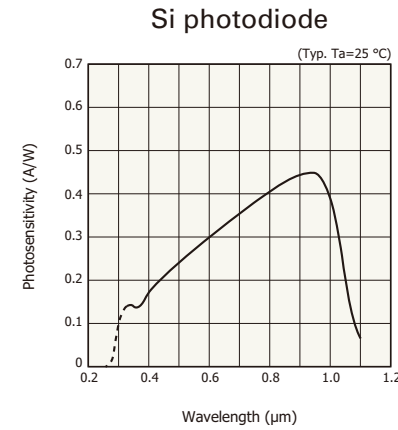
[K1713-05/-08/-09]



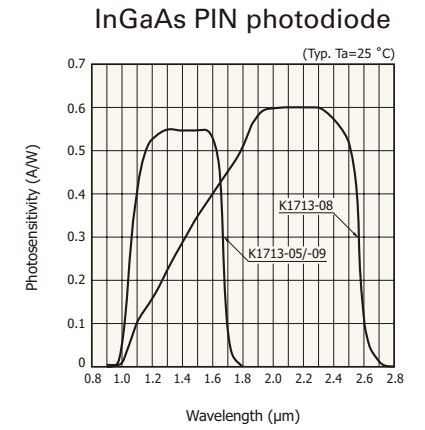
KIRDB0199EB



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KIRDB0199EB

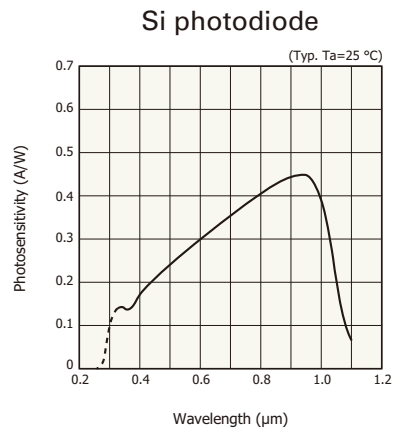


KIRDB0211EB

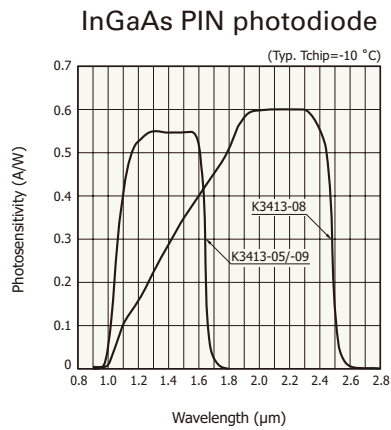
[K3413-05/-08/-09]

[K11908-010K, K13085-010K, K12729-010K]

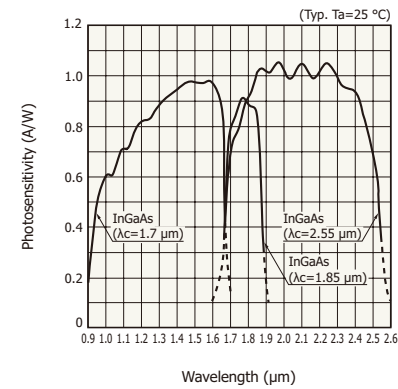
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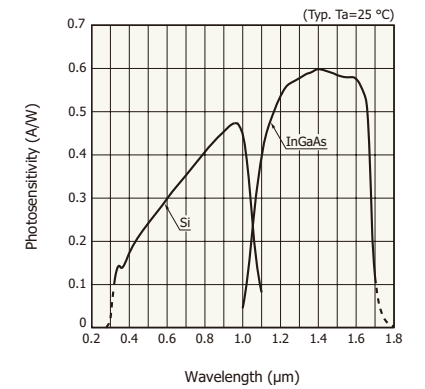
KIRDB0199EB



KIRDB0212EB



KIRDB0661EA



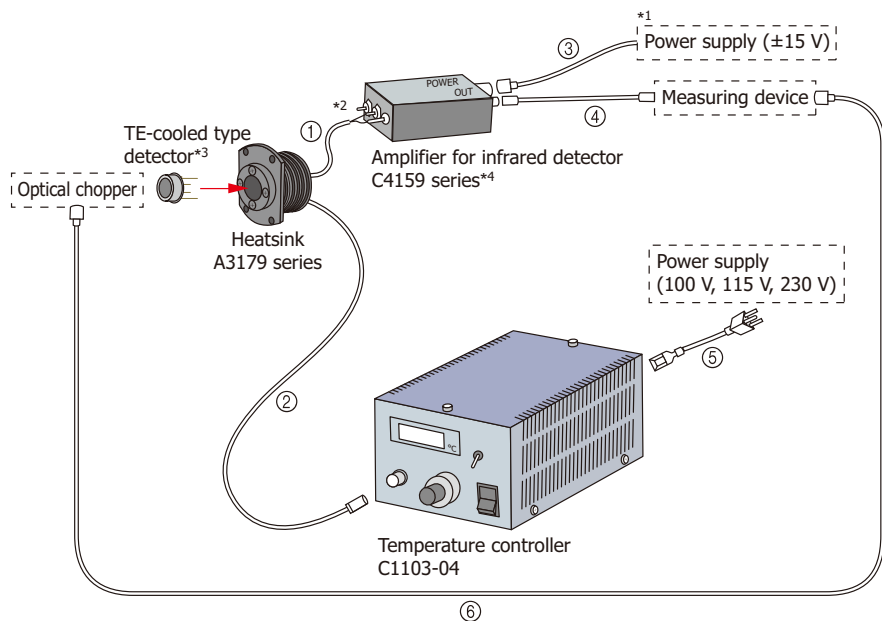
KIRDB0598EC

Accessories for infrared detectors

Hamamatsu provides the following accessories for infrared detectors.

Product name	Type no.	Overview
Temperature controller	C1103-04	The temperature of the TE-cooler inside the detector can be set. Compatible with one-stage and two-stage TE-cooled InAsSb/InAs photovoltaic detectors and InGaAs/Si photodiodes
Valve operator for metal dewar	A3515	The valve operator can be used to re-evacuate the metal dewar. Please be aware of that the detector performance is not guaranteed after re-evacuation at the customer side.
Heatsink (for TE-cooled detector TO-8/TO-3 package)	A3179 series	This heatsink is designed for TE-cooled detectors in 6-pin TO-8 packages and TO-3 packages.

● Connection example



Cable

Cable no.	Cable	Approx. length	Note
①	Coaxial cable (for signals)	2 m	Supplied with heatsink A3179 series. Make the cable as short as possible. (approx. 10 cm is desirable)
②	4-conductor cable (with a connector) A4372-05	3 m	Supplied with temperature controller C1103 series. It is also sold separately.
③	4-conductor cable (with a connector) A4372-02	2 m	Supplied with C4159 series amplifiers for infrared detectors and infrared detector modules with preamp (room temperature type). It is also sold separately.
④	BNC connector cable E2573	1 m	Sold separately
⑤	Power cable (for temperature controller)	1.9 m	Supplied with temperature controller C1103 series
⑥	Cable	-	It needs to be prepared by user side.

*1: Attach the unterminated wire to a 3-4 pin connector or banana plug, then connect it to the power supply.

*2: Soldering is required.

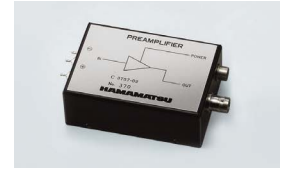
*3: No dedicated socket is available. Soldering is required.

*4: Refer to amplifiers for infrared detectors ([P.24](#)) for details.

KACCC0321EE

Amplifiers for infrared detectors

These are low noise amplifiers for InSb, InAs, InAsSb, and InGaAs detectors.



Product name	Type no.	Conversion impedance 3 range switchable (V/A)	Frequency characteristics Amplifier only, -3 dB	Equivalent input noise current f=1 kHz (pA/Hz ^{1/2})	External power supply (V)	Applicable detectors
Amplifier for photovoltaic detector	C4159-01	10 ⁸ , 10 ⁷ , 10 ⁶	DC to 100 kHz	0.15 (10 ⁸ , 10 ⁷ range) 0.65 (10 ⁶ range)	±15	Dewar type InSb (P5968-060/-100), non-cooled type InAsSb (P13243-022MS, P13894-011MA, P16112-011MA, P16612-011CA/-011CN/-033CF/-039CF/-043CF/-045CF, P16613-011CN, P16614-011CN), TE-cooled type InAsSb (P13243-122MS/-222MS, P13894-211MA), dewar Type II (P15409-901)
	C4159-04	2 × 10 ⁷ , 2 × 10 ⁶ , 2 × 10 ⁵	DC to 45 kHz	0.55	±15	Dewar type InSb (P5968-200)
	C4159-05	10 ⁸ , 10 ⁷ , 10 ⁶	DC to 15 kHz	0.15 (10 ⁸ , 10 ⁷ range) 0.65 (10 ⁶ range)	±15	Dewar type InAs (P7163)
	C4159-06	10 ⁶ , 10 ⁵ , 10 ⁴	DC to 100 kHz	6	±15	TE-cooled type InAs (P10090-11/-21)
	C4159-07	10 ⁶ , 10 ⁵ , 10 ⁴	DC to 100 kHz	10	±15	Non-cooled type InAs (P10090-01), TE-cooled type InAsSb (P11120-201, P12691-201G)
Amplifier for InGaAs PIN photodiode	C4159-03	10 ⁷ , 10 ⁶ , 10 ⁵	DC to 15 kHz	2.5	±15	Non-cooled/TE-cooled type InGaAs (G12180/G12181/G12182/G12183 series)

Accessories

- Instruction manual
- Power cable A4372-02
(with 4-pin connector for amplifier connection, the other side: unterminated wire, 2 m)

Required power supply specifications

- C4159 series: ±15 V ± 0.5
 - Current capacity: 1.5 times or more of amplifier's maximum current consumption
 - Ripple noise: 5 mVp-p or less
 - Analog power supply only
- Recommended DC power supply (example): PW18-3AD [TEXIO], E3630A [Keysight Technologies]

Absolute maximum ratings (Ta= 25 °C)



Parameter	Value	Unit
Supply voltage	±18.0 max.	V
Operating temperature*	0 to +40	°C
Storage temperature*	-20 to +70	°C

* No dew condensation. When there is a temperature difference between a product and the surrounding area in high humidity environments, dew condensation may occur on the product surface. Dew condensation on the product may cause deterioration in characteristics and reliability.

Note: Exceeding the absolute maximum ratings even momentarily may cause a drop in product quality. Always be sure to use the product within the absolute maximum ratings.

Infrared detector modules with preamp




These modules integrate a preamp with an infrared detector of various types. They can detect infrared light simply by connecting a DC power supply.

Type	Type no.	Photo	Detector (type no.)	Photosensitive area (mm)	Cooling	Measurement condition	Cutoff wavelength (μm)	Peak sensitivity wavelength (μm)
						Chip temperature (°C)		
TE-cooled type	C12483-250		InGaAs (G12180-250A)	φ5	TE-cooled	-15	1.66	1.55
	C12485-210		InGaAs (G12182-210K)	φ1			2.05	1.95
	C12486-210		InGaAs (G12183-210K)				2.56	2.3
	C12492-210		InAs (P10090-21)	φ1		-28	3.45	3.25
	C12494-222S NEW		InAsSb (P13243-222MS)	2 × 2		-28	4.1	5.1
	C12494-210S		InAsSb (P11120-201)	φ1			5.9	4.9
	C12494-210M		InAsSb (P12691-201G)				8.3	6.7
	C12494-211L		InAsSb (P13894-211MA)	1 × 1			10.2	5.6
Metal dewar type	G7754-01		InGaAs (G12183-010)*1	φ1	Liquid nitrogen	-196	2.4	2.0
	G7754-03		InGaAs (G12183-030)*1	φ3				
	P7751-01 *2		InSb (P5968-060)	φ0.6			5.5	5.3
	P7751-02 *2		InSb (P5968-200)	φ2				

*1: Chip
*2: FOV=60°

Photodiode modules

These high accuracy photodetectors have a high/low 2-range switching function.

Type no.	Spectral response range (μm)	Peak sensitivity wavelength (μm)	Detector	Photosensitive area (mm)	Cooling	Photo
C10439-10	0.5 to 1.7	1.55	InGaAs	φ1	Non-cooled	
C10439-11	0.5 to 1.7	1.55	InGaAs	φ3		
C10439-15	0.32 to 2.6	0.94	Si	2.4 × 2.4		
		2.3	InGaAs	φ1		

Signal processing unit for photodiode module C10475-01

The C10475-01 is a signal processing unit specifically designed to convert the output of a photodiode module (C10439 series) into digital signals. Digital output (16-bit) can be obtained through serial connection (RS-232C) to a PC.



● Technical notes

[Compound semiconductor photosensors](#)
[Thermopile detectors](#)

● Precautions

[Disclaimer](#)
[Safety consideration](#)
[Metal, ceramic, plastic package products](#)
[Unsealed products](#)
[Surface mount type products](#)
[Compound opto-semiconductors \(photosensors, light emitters\)](#)

● [Inquiries from online](#)

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KIRD0001E17 Mar. 2023 DN

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